



ALPHA & OMEGA
SEMICONDUCTOR, LTD



AO8803

Dual P-Channel Enhancement Mode Field Effect Transistor

General Description

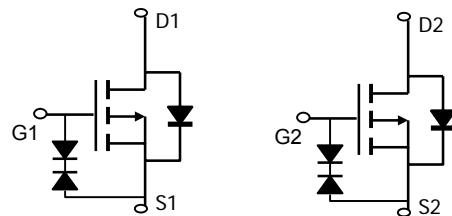
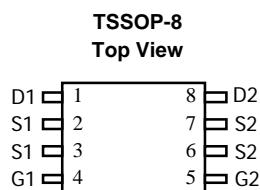
The AO8803/L uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 1.8V. This device is suitable for use as a load switch or in PWM applications. It is ESD protected. AO8803 and AO8803L are electrically identical.

-RoHS Compliant

-AO8803L is Halogen Free

Features

V_{DS} (V) = -12V
 I_D = -7 A (V_{GS} = -4.5V)
 $R_{DS(ON)} < 18m\Omega$ (V_{GS} = -4.5V)
 $R_{DS(ON)} < 22m\Omega$ (V_{GS} = -2.5V)
 $R_{DS(ON)} < 29m\Omega$ (V_{GS} = -1.8V)
 ESD Rating: 4KV HBM



Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

Parameter	Symbol	Maximum		Units
Drain-Source Voltage	V_{DS}	-12		V
Gate-Source Voltage	V_{GS}	± 8		V
Continuous Drain Current ^A	I_D	-7		A
$T_A=70^\circ C$		-5.8		
Pulsed Drain Current ^B	I_{DM}	-30		
Power Dissipation ^A	P_D	1.4		W
$T_A=70^\circ C$		0.9		
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 150		°C

Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ^A	$R_{\theta JA}$	73	90	°C/W
Steady-State		96	125	°C/W
Maximum Junction-to-Lead ^C	$R_{\theta JL}$	63	75	°C/W

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D=-250\mu\text{A}, V_{GS}=0\text{V}$	-12			V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=-9.6\text{V}, V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$			-1 -5	μA
I_{GSS}	Gate-Body leakage current	$V_{DS}=0\text{V}, V_{GS}=\pm 4.5\text{V}$ $V_{DS}=0\text{V}, V_{GS}=\pm 8\text{V}$			± 1 ± 10	μA
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=-250\mu\text{A}$	-0.3	-0.55	-1	
$I_{D(\text{ON})}$	On state drain current	$V_{GS}=-4.5\text{V}, V_{DS}=-5\text{V}$	-30			A
$R_{\text{DS(ON)}}$	Static Drain-Source On-Resistance	$V_{GS}=-4.5\text{V}, I_D=-7\text{A}$ $T_J=125^\circ\text{C}$		15 19	18 23	$\text{m}\Omega$
		$V_{GS}=-2.5\text{V}, I_D=-6\text{A}$			18	$\text{m}\Omega$
		$V_{GS}=-1.8\text{V}, I_D=-5\text{A}$			22	$\text{m}\Omega$
		$V_{GS}=-1.5\text{V}, I_D=-1\text{A}$			28	$\text{m}\Omega$
g_{FS}	Forward Transconductance	$V_{DS}=-5\text{V}, I_D=-7\text{A}$		34		S
V_{SD}	Diode Forward Voltage	$I_S=-1\text{A}, V_{GS}=0\text{V}$		-0.78	-1	V
I_s	Maximum Body-Diode Continuous Current				-2.5	A
DYNAMIC PARAMETERS						
C_{iss}	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=-6\text{V}, f=1\text{MHz}$		3960	4750	pF
C_{oss}	Output Capacitance			910		pF
C_{rss}	Reverse Transfer Capacitance			757		pF
R_g	Gate resistance	$V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$		6.9	8.5	Ω
SWITCHING PARAMETERS						
Q_g	Total Gate Charge	$V_{GS}=-4.5\text{V}, V_{DS}=-6\text{V}, I_D=-7\text{A}$		36.6	44	nC
Q_{gs}	Gate Source Charge			3.4		nC
Q_{gd}	Gate Drain Charge			10		nC
$t_{D(\text{on})}$	Turn-On Delay Time	$V_{GS}=-4.5\text{V}, V_{DS}=-6\text{V}, R_L=0.86\Omega, R_{\text{GEN}}=3\Omega$		15		ns
t_r	Turn-On Rise Time			43		ns
$t_{D(\text{off})}$	Turn-Off Delay Time			158		ns
t_f	Turn-Off Fall Time			95		ns
t_{rr}	Body Diode Reverse Recovery Time		$I_F=-7\text{A}, dI/dt=100\text{A}/\mu\text{s}$	49	60	ns
Q_{rr}	Body Diode Reverse Recovery Charge	$I_F=-7\text{A}, dI/dt=100\text{A}/\mu\text{s}$		19.4		nC

A: The value of R_{JJA} is measured with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The value in any given application depends on the user's specific board design. The current rating is based on the $t \leq 10\text{s}$ thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The R_{JJA} is the sum of the thermal impedance from junction to lead R_{JL} and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The SOA curve provides a single pulse rating.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

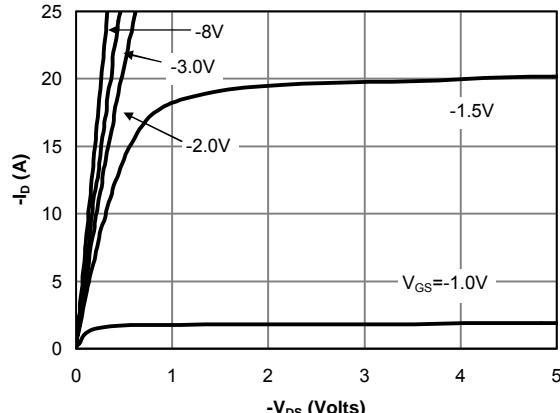


Fig 1: On-Region Characteristics

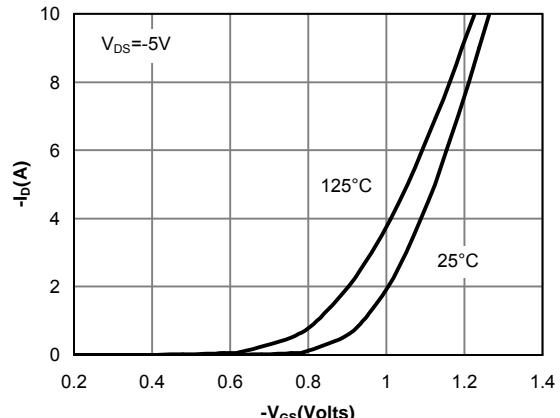


Figure 2: Transfer Characteristics

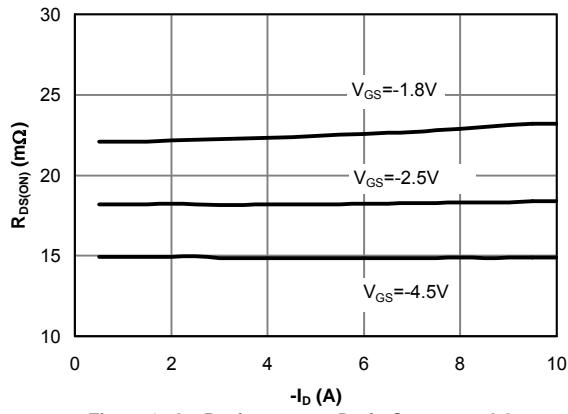


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

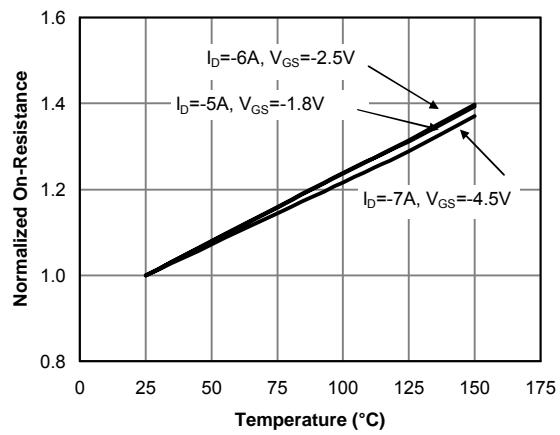


Figure 4: On-Resistance vs. Junction Temperature

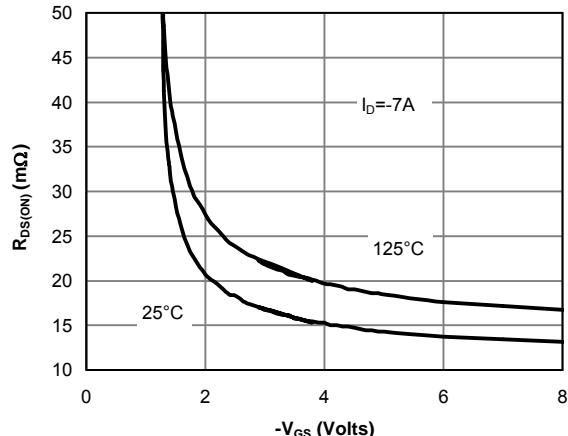


Figure 5: On-Resistance vs. Gate-Source Voltage

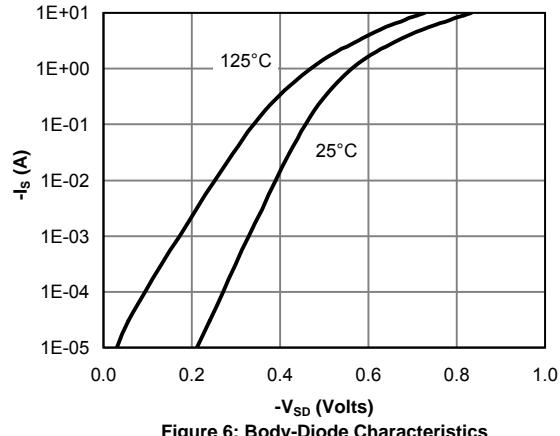


Figure 6: Body-Diode Characteristics

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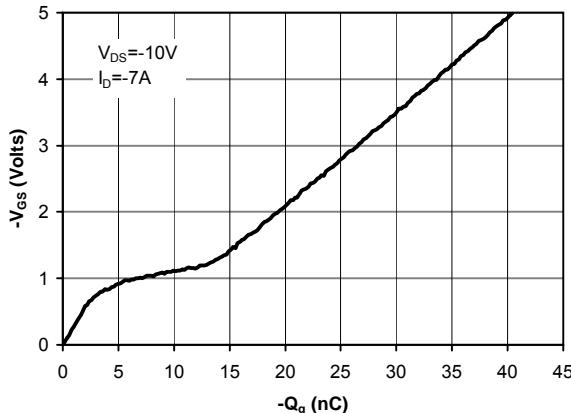


Figure 7: Gate-Charge Characteristics

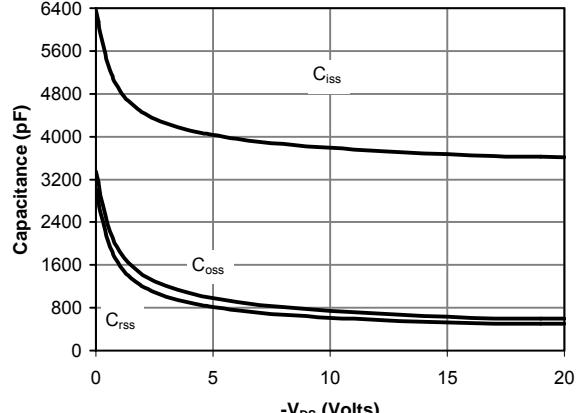


Figure 8: Capacitance Characteristics

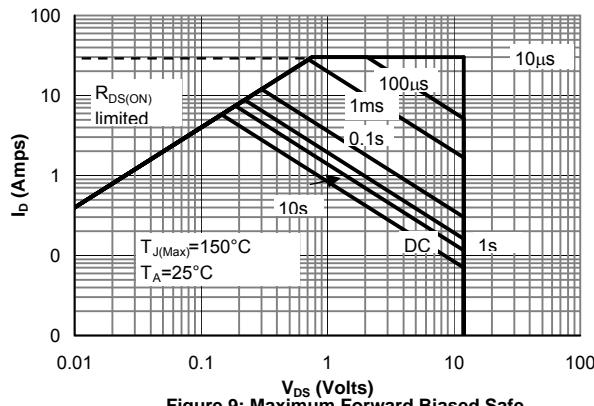


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

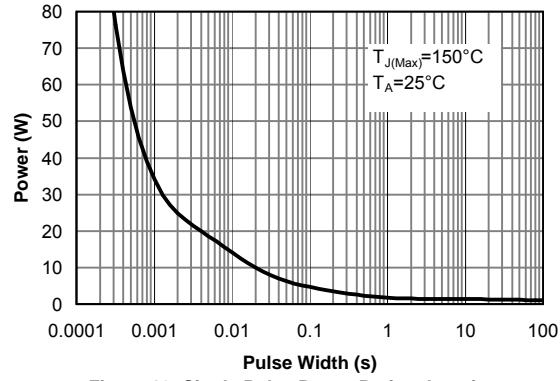


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

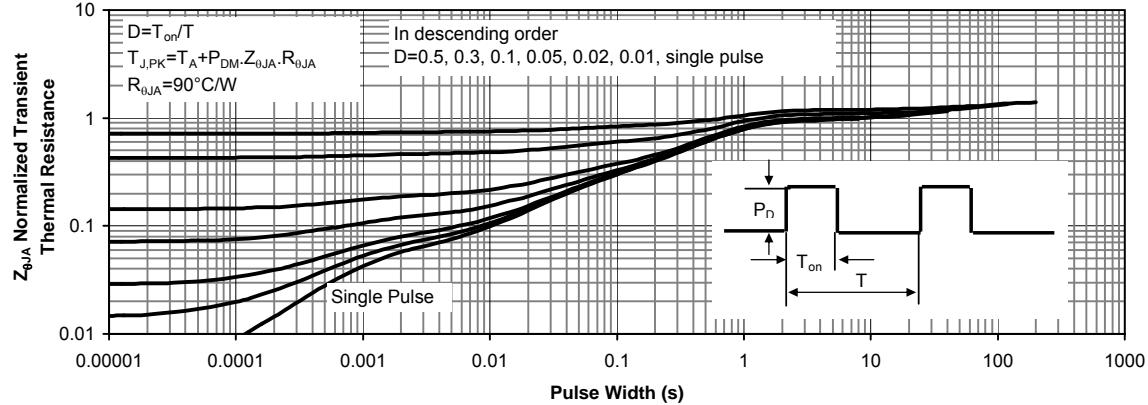


Figure 11: Normalized Maximum Transient Thermal Impedance